Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination CHIU ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0221322	11-2004	Shen et al.	725/135
*	В	US-6,429,883	08-2002	Plow et al.	715/768
*	С	US-5,933,141	08-1999	Smith, Kim C.	725/39
*	D	US-5,651,107	07-1997	Frank et al.	715/768
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	. 1	US-			
	J	US-			
	К	US-			
	L	US-			
	M,	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 990998 A2	04-2000	European Patent	TAKATA et al.	G06F 17/30
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.